

# P-Channel 60-V (D-S) MOSFET

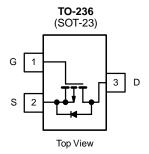
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	- 60				
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = - 10 V	0.04			
Q <sub>g</sub> (Max.) (nC)	12				
Q <sub>gs</sub> (nC)	3.8				
Q <sub>gd</sub> (nC)	5.1				
Configuration	Single				

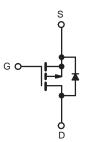
#### **FEATURES**

- · Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz



- Sink to Lead Creepage Distance = 4.8 mm
- P-Channel
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		$V_{DS}$	- 60	V		
Gate-Source Voltage			$V_{GS}$	± 20	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Continuous Drain Current	$V_{GS}$ at - 10 V $\frac{T_C = 25}{T_C = 100}$	T <sub>C</sub> = 25 °C		- 5.2		
Continuous Dialii Curient	VGS at - 10 V	$T_C = 100 ^{\circ}C$	I <sub>D</sub>	- 3.8	Α	
Pulsed Drain Current <sup>a</sup>			$I_{DM}$	- 21		
Linear Derating Factor				0.18	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	120	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	- 5.2	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	2.7	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		$P_{D}$	27	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	- 4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>			
Mounting Torque	6-32 or N	6-32 or M3 screw		10	lbf ⋅ in	
Wounting Forque	0-52 of M3 Sciew			1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 5.0 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 5.3 A (see fig. 12). c.  $I_{SD}$  < 6.7 A, dI/dt < 90 A/µs,  $V_{DD}$   $\leq$   $V_{DS}$ ,  $V_{DS}$  = 175 °C.

- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	65	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	5.5	C/VV		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		•					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		- 60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = - 1 mA		- 0.060	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 1.0	-	- 2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zara Cata Valtaga Drain Current	1	V <sub>DS</sub> = - 60 V, V <sub>GS</sub> = 0 V		-	-	- 100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 48	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	- 500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 3.2 A <sup>b</sup>	-	0.05	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	- 25 V, I <sub>D</sub> = - 3.2 A <sup>b</sup>	1.6	-	-	S
Dynamic		•					
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	270	-	- pF
Output Capacitance	C <sub>oss</sub>		V <sub>DS</sub> = - 25 V,	-	170	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	31	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Qg			-	-	12	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = - 10 V	$V_{GS} = -10 \text{ V}$ $I_D = -4.7 \text{ A}, V_{DS} = -48 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	3.8	nC
Gate-Drain Charge	Q <sub>gd</sub>	7	goo ng. o ana ro	-	-	5.1	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = - 30 V, $I_{D}$ = - 4.7 A, $R_{G}$ = 24 $\Omega$ $R_{D}$ = 4.0 $\Omega$ , see fig. 10 <sup>b</sup>		-	11	-	- ns
Rise Time	t <sub>r</sub>			-	63	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	9.6	-	
Fall Time	t <sub>f</sub>			-	31	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	1			•	l.	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	- 5.2	А
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 21	^
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = - 5.2 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	- 5 .5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 4.7 A, dl/dt = 100 A/μs <sup>b</sup>		-	80	160	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.096	0.19	μC
Forward Turn-On Time	ton	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L			_D)		

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

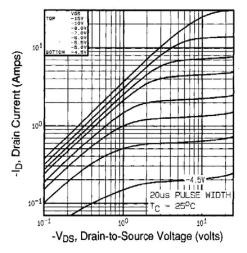


Fig. 1 - Typical Output Characteristics, T<sub>C</sub>= 25 °C

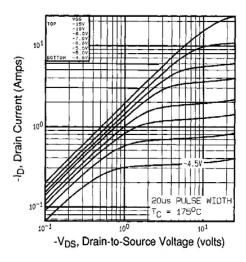
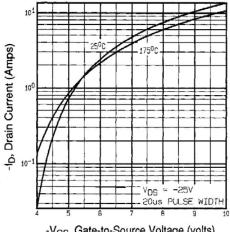


Fig. 2 - Typical Output Characteristics,  $T_{C}$ = 175 °C



-V<sub>GS</sub>, Gate-to-Source Voltage (volts)

Fig. 3 - Typical Transfer Characteristics

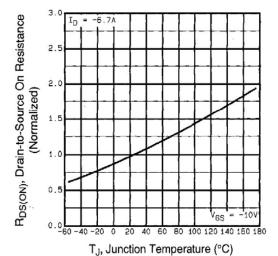


Fig. 4 - Normalized On-Resistance vs. Temperature



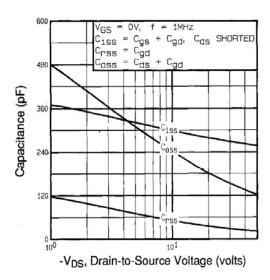


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

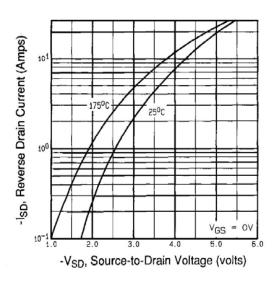


Fig. 7 - Typical Source-Drain Diode Forward Voltage

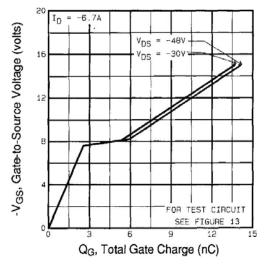


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

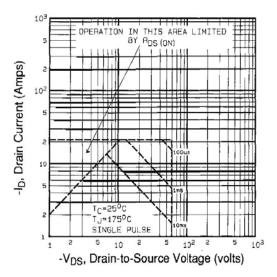


Fig. 8 - Maximum Safe Operating Area



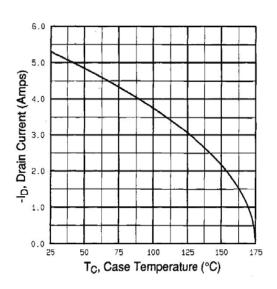


Fig. 9 - Maximum Drain Current vs. Case Temperature

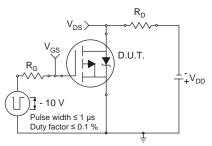


Fig. 10a - Switching Time Test Circuit

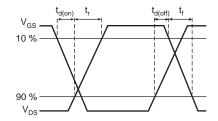


Fig. 10b - Switching Time Waveforms

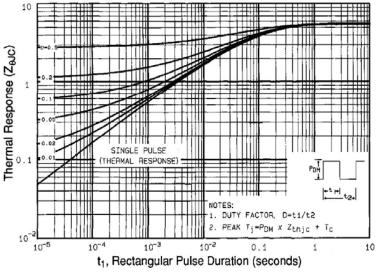


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

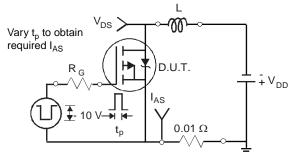


Fig. 12a - Unclamped Inductive Test Circuit

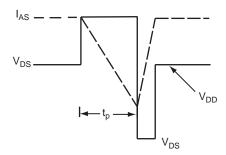


Fig. 12b - Unclamped Inductive Waveforms



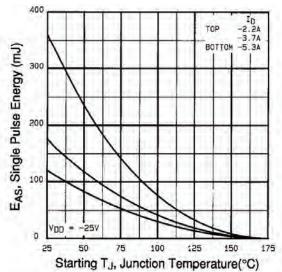


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

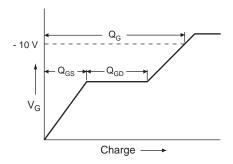


Fig. 13a - Basic Gate Charge Waveform

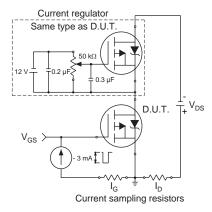
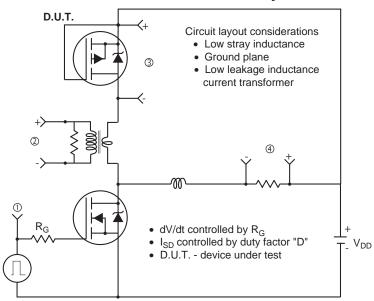


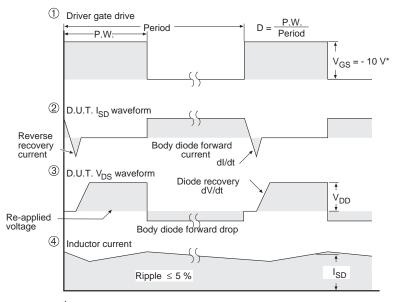
Fig. 13b - Gate Charge Test Circuit



# Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

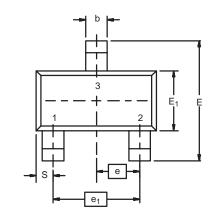


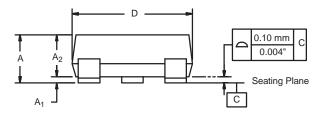
V<sub>GS</sub> = -5 V for logic level and -3 V drive devices

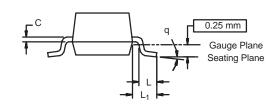
Fig. 14 - For P-Channel



# SOT-23 (TO-236): 3-LEAD





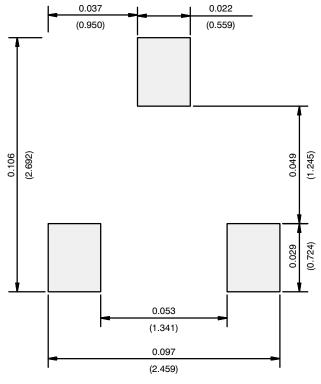


Dim	MILLIN	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A <sub>1</sub>	0.01	0.10	0.0004	0.004	
A <sub>2</sub>	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E <sub>1</sub>	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e <sub>1</sub>	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L <sub>1</sub>	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	
ECN: S-03946-Rev. K. 09-	Jul-01				

DWG: 5479



## **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)



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